

ZXMN3F318DN8 30V SO8 Asymmetrical dual N-channel enhancement mode MOSFET

Summary

Device	V _{(BR)DSS}	Q _G (nC)	R _{DS(on)} (Ω)	I _D (A)
Q1	30	12.9	0.024 @ V _{GS} = 10V	7.3
390 11		W W W.	0.039 @ V _{GS} = 4.5V	5.7
Q2	30	9	0.035 @ V _{GS} = 10V	6
			0.055 @ V _{GS} = 4.5V	4.8



Description

This new generation dual Trench MOSFET from Zetex features low on-resistance achievable with low (4.5V) gate drive.

Features

- Low on-resistance
- 4.5V gate drive capability
- Low profile SOIC package

Applications

- DC-DC Converters
- SMPS
- Load switching
- Motor control
- Backlighting

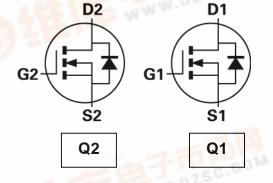
Ordering information

Device	Reel size	Tape width	Quantity
	(inches)	(mm)	per reel
ZXMN3F318DN8TA	7	12	500

Device marking

ZXMN





S1⊡	0	D1
G1□□		⊥D1
S2□		□ D2
G2 □ □		□D2

Pinout – top view

ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	LIMIT	LIMIT	UNIT
		Q1	Q2	
Drain-Source Voltage	V _{DSS}	30	30	V
Gate-Source Voltage	V _{GS}	± 20	± 20	V
Continuous Drain Current V_{GS} =10V; T _A =25°C (b)	I _D	7.3	6	А
V_{GS} =10V; T _A =70°C (b)		5.9	4.8	
V _{GS} =10V; T _A =25°C (a)		5.7	4.6	
Pulsed Drain Current (c)	I _{DM}	33	25	А
Continuous Source Current (Body Diode) (b)	I _S	3.5	3.3	А
Pulsed Source Current (Body Diode) (c)	I _{SM}	33	25	А
Power Dissipation at $T_A = 25^{\circ}C$ (a) (d)	P _D	1.25		W
Linear Derating Factor		1	0	mW/°C
Power Dissipation at $T_A = 25^{\circ}C$ (a) (e)	P _D	1.8		W
Linear Derating Factor		1	4	mW/°C
Power Dissipation at $T_A = 25^{\circ}C$ (b) (d)	P _D	2	.1	W
Linear Derating Factor		1	7	mW/°C
Operating and Storage Temperature Range	T _i , T _{stg}	-55 to	+150	°C

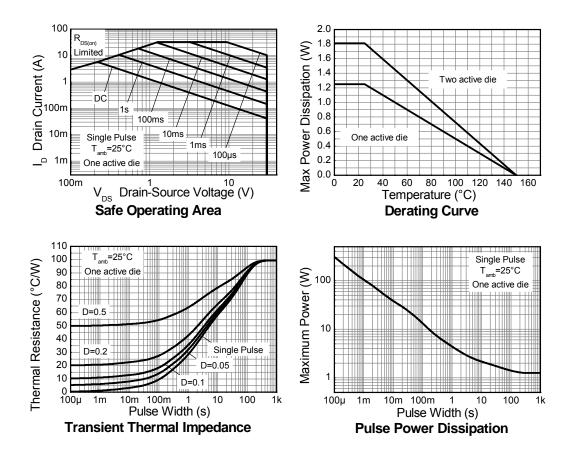
THERMAL RESISTANCE

PARAMETER	SYMBOL	VALUE	UNIT
Junction to Ambient (a) (d)	$R_{\theta JA}$	100	°C/W
Junction to Ambient (a) (e)	$R_{ extsf{ heta}JA}$	70	°C/W
Junction to Ambient (b) (d)	R _{θJA}	60	°C/W
Junction to Lead (f)	$R_{ extsf{ heta}JL}$	53	°C/W

NOTES

- (a) For a device surface mounted on 25mm x 25mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.
- (b) For a device surface mounted on FR4 PCB measured at t \leq 10 sec.
- (c) Repetitive rating 25mm x 25mm FR4 PCB, D=0.02, pulse width 300us pulse width limited by maximum junction temperature.
- (d) For a dual device with one active die.
- (e) For a device with two active die running at equal power.
- (f) Thermal resistance from junction to solder-point (at the end of the drain lead).

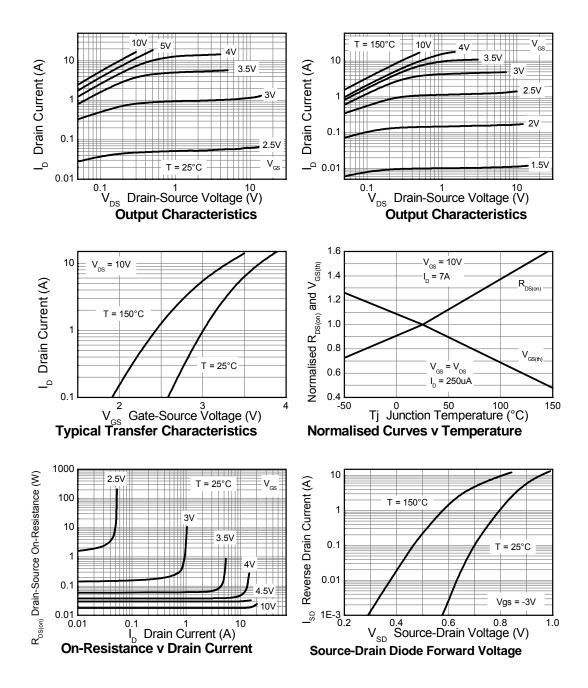
Q1 Thermal Characteristics



PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	CONDITIONS
STATIC					-	
Drain-Source Breakdown Voltage	V _{(BR)DSS}	30			V	ID= 250μA, VGS=0V
Zero Gate Voltage Drain Current	I _{DSS}			0.5	μA	V _{DS} = 30V, V _{GS} =0V
Gate-Body Leakage	I _{GSS}			100	nA	V _{GS} =±20V, V _{DS} =0V
Gate-Source Threshold Voltage	V _{GS(th)}	1.0		3.0	V	ID= 250μΑ, VDS=VGS
Static Drain-Source On-State Resistance (1)	$R_{DS(on)}$			0.024	Ω	V _{GS} = 10V, I _D = 7.0A
				0.039	Ω	V _{GS} = 4.5V, I _D = 6.0A
Forward Transconductance (1) (3)	g _{fs}		16.5		S	V _{DS} = 15V, I _D = 7A
DYNAMIC (3)						
Input Capacitance	C _{iss}		608		pF	V _{DS} = 15V, V _{GS} =0V
Output Capacitance	Coss		132		pF	f=1MHz
Reverse Transfer Capacitance	C _{rss}		71		pF	
SWITCHING (2) (3)						
Turn-On-Delay Time	t _{d(on)}		2.9		ns	V _{DD} = 15V, I _D = 1A
Rise Time	t _r		3.3		ns	R _G ≅6.0Ω, V _{GS} = 10V
Turn-Off Delay Time	t _{d(off)}		16		ns	
Fall Time	t _f		8		ns	
Total Gate Charge	Qg		12.9		nC	V _{DS} = 15V, V _{GS} = 10V
Gate-Source Charge	Q_{gs}		2.5		nC	I _D = 7A
Gate Drain Charge	Q _{gd}		2.52		nC	
SOURCE-DRAIN DIODE						
Diode Forward Voltage (1)	V_{SD}		0.82	1.2	V	Tj=25°C, IS= 1.7A, VGS=0V
Reverse Recovery Time (3)	t _{rr}		12		ns	Tj=25°C, IS= 2.2A,
Reverse Recovery Charge (3)	Q _{rr}				di/dt=100A/µs	

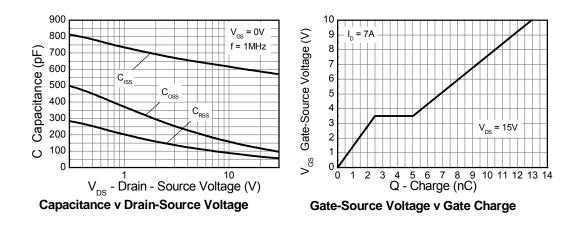
Q1 ELECTRICAL CHARACTERISTICS (at T_{amb} = 25°C unless otherwise stated).

Measured under pulsed conditions. Pulse width = 300µs. Duty cycle ≤ 2%.
Switching characteristics are independent of operating junction temperature.
For design aid only, not subject to production testing.



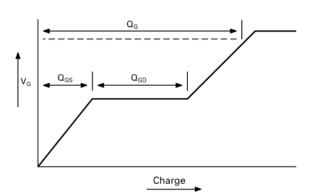
Q1 Typical Characteristics

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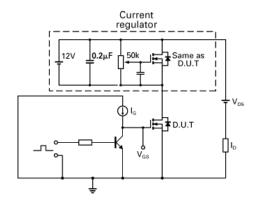


Test Circuits

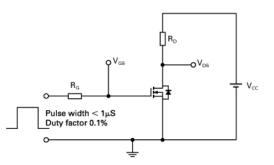
V_{DS} 90%



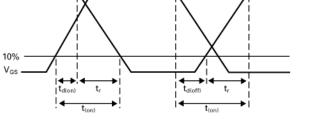
Basic gate charge waveform



Gate charge test circuit



Switching time test circuit



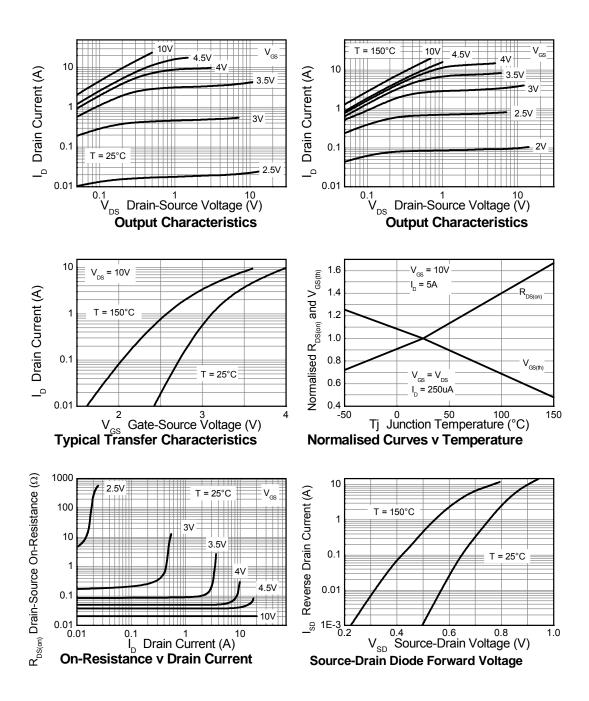
Switching time waveforms

PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	CONDITIONS
STATIC						-
Drain-Source Breakdown Voltage	V _{(BR)DSS}	30			V	I _D = 250μΑ, V _{GS} =0V
Zero Gate Voltage Drain Current	I _{DSS}			0.5	μA	V _{DS} = 30V, V _{GS} =0V
Gate-Body Leakage	I _{GSS}			100	nA	V _{GS} =±20V, V _{DS} =0V
Gate-Source Threshold Voltage	V _{GS(th)}	1.0		3.0	V	ID= 250μΑ, VDS=VGS
Static Drain-Source On-State Resistance (1)	R _{DS(on)}			0.035	Ω	V _{GS} = 10V, I _D = 5.0A
				0.055	Ω	V _{GS} = 4.5V, I _D = 4A
Forward Transconductance (1) (3)	g _{fs}		11.8		S	V _{DS} = 15V, I _D = 5A
DYNAMIC (3)						
Input Capacitance	C _{iss}		430		pF	V _{DS} = 15V, V _{GS} =0V
Output Capacitance	C _{oss}		101		pF pF	f=1MHz
Reverse Transfer Capacitance	C _{rss}		56			
SWITCHING (2) (3)						
Turn-On-Delay Time	t _{d(on)}		2.5		ns	V _{DD} = 15V, I _D = 1A
Rise Time	t _r		3.3		ns	R _G ≅6.0Ω, V _{GS} = 10V
Turn-Off Delay Time	t _{d(off)}		11.5		ns	
Fall Time	t _f		6.3		ns	
Total Gate Charge	Qg		9		nC	V _{DS} = 15V, V _{GS} = 10V
Gate-Source Charge	Q_{gs}		1.7		nC	I <mark>D</mark> = 5A
Gate Drain Charge	Q _{gd}		2		nC	
SOURCE-DRAIN DIODE						
Diode Forward Voltage (1)	V_{SD}		0.82	1.2	V	Tj=25°C, IS= 1.7A, V _{GS} =0V
Reverse Recovery Time (3)	t _{rr}		12		ns	Tj=25°C, IS= 2.1A,
Reverse Recovery Charge (3)	Q _{rr}		4.9		nC	di/dt=100A/µs

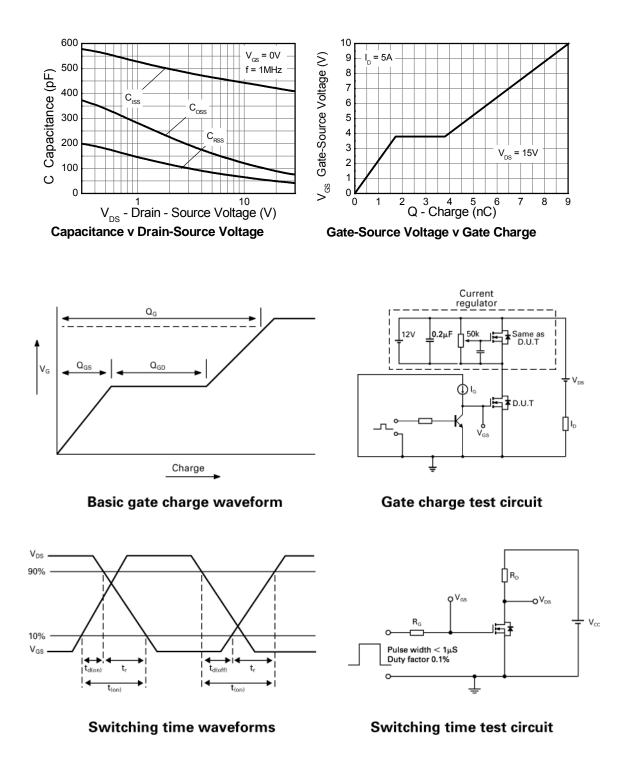
Q2 ELECTRICAL CHARACTERISTICS (at T_{amb} = 25°C unless otherwise stated).

 $\begin{array}{ll} 1 \mbox{ Measured under pulsed conditions. Pulse width = $300 \mu s$. Duty cycle $\le 2\%$. \\ 2 \mbox{ Switching characteristics are independent of operating junction temperature.} \\ 3 \mbox{ For design aid only, not subject to production testing.} \end{array}$

Q2 Typical Characteristics

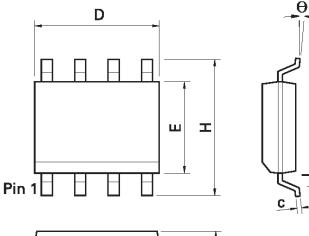


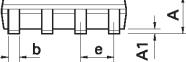
Q2 Typical Characteristics



Packaging details – SO8

Package outline





Seating Plane

DIM	Inches		Millin	illimeters DIM		Inc	hes	Millin	neters
	Min.	Max.	Min.	Max.	1	Min.	Max.	Min.	Max.
А	0.053	0.069	1.35	1.75	е	0.050	BSC	1.27	BSC
A1	0.004	0.010	0.10	0.25	b	0.013	0.020	0.33	0.51
D	0.189	0.197	4.80	5.00	с	0.008	0.010	0.19	0.25
Н	0.228	0.244	5.80	6.20	θ	0°	8°	0°	8°
E	0.150	0.157	3.80	4.00	h	0.010	0.020	0.25	0.50
L	0.016	0.050	0.40	1.27	-	-	-	-	-

Note: Controlling dimensions are in inches. Approximate dimensions are provided in millimeters

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